



## 1 Cover Page

# RF MPE REPORT

**Application No.:** SHEM2005003804CR  
**FCC ID:** 2ADTD-2DE2204IW  
**IC:** 20199-2DE2204IW  
**Applicant:** Hangzhou Hikvision Digital Technology Co., Ltd  
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**Manufacturer:** Hangzhou Hikvision Digital Technology Co.,Ltd  
**Address of Manufacturer:** No.555 Qianmo Road, Binjiang District, Hangzhou 310052, China  
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2.No.299,Qiushi Road,Tonglu Economic Development Zone,Tonglu County,Hangzhou,Zhejiang,310052,China.  
3. No. 118, Haikang Road, Area C, Jianqiao Industrial Park, Dadukou District, Chongqing, 401325,China  
**Equipment Under Test (EUT):**  
**EUT Name:** MINI PTZ CAMERA  
**Model No.:** DS-2DE2204IW-DE3/W  
**Add Model No.:** Refer Page 2  
**Trade mark:** HIKVISION  
**Standard(s) :** FCC Rules 47 CFR §2.1091  
KDB447498 D01 General RF Exposure Guidance v06  
RSS-102 Issue 5 (March 2015)  
**Date of Receipt:** 2020-05-25  
**Date of Test:** 2020-05-25 to 2020-06-04  
**Date of Issue:** 2020-06-10

|                     |              |
|---------------------|--------------|
| <b>Test Result:</b> | <b>Pass*</b> |
|---------------------|--------------|

\* In the configuration tested, the EUT complied with the standards specified above.

Parlan Zhan

Parlan Zhan  
E&E Section Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.



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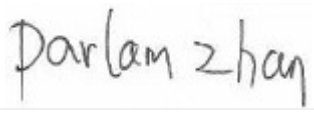


For FCC Model No: DS-2DE2204IW-DE3/W, DS-2DE2402IW-DE3/W, DS-2DE2ABCDE-UVW/XYZ (The "A", "B", "C", "D", "E", "U", "V", "W", "X", "Y" and "Z" in the model name mean: A=0-9, A-Z or blank; B=0-9, A-Z or blank; C=0-9, A-Z or blank; D=0-9, A-Z or blank; E=0-9, A-Z or blank; U= 0-9, A-Z or blank; V= 0-9, A-Z or blank; W= 0-9, A-Z or blank; X=0-9, A-Z or blank; Y=0-9, A-Z or blank; Z=0-9, A-Z or blank or "-" or "\*" or "/" )

For IC Model No : DS-2DE2204IW-DE3/W, DS-2DE2402IW-DE3/W



| Revision Record |             |            |        |
|-----------------|-------------|------------|--------|
| Version         | Description | Date       | Remark |
| 00              | Original    | 2020-06-10 | /      |
|                 |             |            |        |
|                 |             |            |        |

|                             |  |                                                                                    |  |  |
|-----------------------------|--|------------------------------------------------------------------------------------|--|--|
| Authorized for issue<br>by: |  |                                                                                    |  |  |
|                             |  |   |  |  |
|                             |  | Micheal Niu / Project Engineer                                                     |  |  |
|                             |  |  |  |  |
|                             |  | Parlam Zhan / Reviewer                                                             |  |  |



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### 3 General Information

#### 3.1 General Description of E.U.T.

|                   |                                        |
|-------------------|----------------------------------------|
| Power supply:     | DC 12V or PoE(802.3af,DC 36-57V) 0.35A |
| Serial Number:    | E09120063                              |
| Firmware Version: | IPD_R7_EN_STD_5.6.15_200402            |

#### 3.2 Technical Specifications

|                      |                                                                                 |
|----------------------|---------------------------------------------------------------------------------|
| Modulation Type:     | 802.11b: DSSS (CCK, DQPSK, DBPSK)<br>802.11g/n: OFDM (64QAM, 16QAM, QPSK, BPSK) |
| Number of Channels:  | 802.11b/g/n(HT20):11<br>802.11n(HT40):7                                         |
| Operation Frequency: | 802.11b/g/n(HT20): 2412MHz to 2462MHz<br>802.11n(HT40): 2422MHz to 2452MHz      |
| Antenna Gain:        | 1.28dBi                                                                         |
| Antenna Type:        | Integral Antenna                                                                |
| Channel Spacing:     | 5MHz                                                                            |

### 3.3 Test Location

All tests were performed at:

Compliance Certification Services (Kunshan) Inc.

No.10 Weiye Rd, Innovation park, Eco&Tec, Development Zone, Kunshan City, Jiangsu, China.

Tel: +86 512 5735 5888 Fax: +86 512 5737 0818

No tests were sub-contracted.

### 3.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L4354)**

CNAS has accredited Compliance Certification Services (Kunshan) Inc. to ISO/IEC 17025:2017 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **A2LA (Certificate No. 2541.01)**

Compliance Certification Services (Kunshan) Inc. is accredited by the American Association for Laboratory Accreditation (A2LA). Certificate No. 2541.01.

- **FCC (Designation Number: CN1172)**

Compliance Certification Services Inc. has been recognized as an accredited testing laboratory. Designation Number: CN1172.

- **ISED (CAB identifier: CN0072)**

Compliance Certification Services (Kunshan) Inc. has been recognized by Innovation, Science and Economic Development Canada (ISED) as an accredited testing laboratory.

CAB Identifier: CN0072.

- **VCCI (Member No.: 1938)**

The 3m and 10m Semi-anechoic chamber and Shielded Room of Compliance Certification Services (Kunshan) Inc. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-1600, C-1707, T-1499, G-10216 respectively.

## 4 Test Standards and Limits

### 4.1 FCC Radiofrequency radiation exposure limits:

According to §1.1310, the limit for general population/uncontrolled exposures

| Frequency     | Power density(mW/cm <sup>2</sup> ) | Averaging time(minutes) |
|---------------|------------------------------------|-------------------------|
| 300MHz~1.5GHz | $f/1500$                           | 30                      |
| 1.5GHz~100GHz | 1.0                                | 30                      |

### 4.2 IC Radiofrequency radiation exposure limits:

According to RSS-102 section 2.5.2, RF exposure evaluation is required if the separation distance between the user and/or bystander and the device's radiating element is greater than 20 cm, except when the device operates as follows:

below 20 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 1 W (adjusted for tune-up tolerance);

- at or above 20 MHz and below 48 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than  $4.49/f^{0.5}$  W (adjusted for tune-up tolerance), where  $f$  is in MHz;
- at or above 48 MHz and below 300 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 0.6 W (adjusted for tune-up tolerance);
- at or above 300 MHz and below 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than  $1.31 \times 10^{-2} f^{0.6834}$  W (adjusted for tune-up tolerance), where  $f$  is in MHz;
- at or above 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 5 W (adjusted for tune-up tolerance).

For 2.4G device, the limit of worse case is 2.68 W



## 5 Measurement and Calculation

### 5.1 Maximum transmit power

The Power Data is based on the RF Test Report SHEM200500380401

| Test Mode | Test Channel | Ant  | Power [dBm] | Power [mW]   |
|-----------|--------------|------|-------------|--------------|
| 11B       | 2412         | Ant1 | 16.69       | 46.67        |
| 11B       | 2437         | Ant1 | 17.28       | 53.46        |
| 11B       | 2462         | Ant1 | 17.57       | 57.15        |
| 11G       | 2412         | Ant1 | 17.55       | 56.89        |
| 11G       | 2437         | Ant1 | 17.98       | 62.81        |
| 11G       | 2462         | Ant1 | 18.13       | <b>65.01</b> |
| 11N20SISO | 2412         | Ant1 | 16.20       | 41.69        |
| 11N20SISO | 2437         | Ant1 | 16.30       | 42.66        |
| 11N20SISO | 2462         | Ant1 | 16.41       | 43.75        |
| 11N40SISO | 2422         | Ant1 | 14.41       | 27.61        |
| 11N40SISO | 2437         | Ant1 | 14.45       | 27.86        |
| 11N40SISO | 2452         | Ant1 | 14.88       | 30.76        |



## 5.2 MPE Calculation

For FCC:

According to the formula  $S=P/4\pi R^2$ , we can calculate S which is MPE.

Note:

- 1) P (mW)
- 2) R = distance to the center of radiation of antenna (in meter) = 20cm
- 3) MPE limit = 1mW/cm<sup>2</sup>

The max. antenna gain is 1.28 dBi

| Max.<br>Conducted<br>Power<br>P(mW) | Gain in Linear<br>Scale<br>G | Operation<br>Distance<br>R(cm) | Power<br>Density<br>(mW/cm <sup>2</sup> ) | Limit<br>(mW/cm <sup>2</sup> ) | Result |
|-------------------------------------|------------------------------|--------------------------------|-------------------------------------------|--------------------------------|--------|
| 65.01                               | 1.343                        | 20                             | 0.01737                                   | 1                              | Pass   |

For IC:

$$E.I.R.P.= P \cdot G = 0.06501 \times 1.343 = 0.0873W < 2.68W$$

So the device is exclusion from SAR test.

**--End of the Report--**